

Notice of References Cited

Application No.	9/117447	Applicant(s)	Lubitz et al
Examiner	Manfield	Group Art Unit	1645

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B	5874267	2/1999	DEBLAERE et al	—	—
C	5470573	11/1995	LUBITZ et al	—	—
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O	9734000	9/1999	WO	SMIT et al	Abstract only	
P	19603649	8/1997	DE	LUBITZ et al	Abstract only	
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V	Kuen et al, Gene, 145:115-120	1994
W	Bahl et al, FEMS Microbiol Rev. 20:47-98	1997
X	Kuen et al, J. Bacteriol., 179/5:1664-1670	1997

* A copy of this reference is not being furnished with this Office action.
 (See Manual of Patent Examining Procedure, Section 707.05(a).)

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